



MJ N-Channel Enhancement Mode Power MOSFET

Description

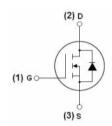
The MJ0117K uses advanced trench technology and design to provide excellent $R_{\text{DS}(\text{ON})}$ with low gate charge. It can be used in a wide variety of applications.

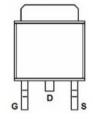
General Features

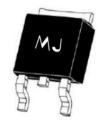
- $ightharpoonup V_{DS} = 100V, I_D = 17A$ $R_{DS(ON)} < 70 m\Omega$ @ $V_{GS} = 10V$ (Typ:56mΩ) $R_{DS(ON)} < 85 m\Omega$ @ $V_{GS} = 4.5V$ (Typ:65mΩ)
- ◆ High density cell design for ultra low Rdson
- ◆ Fully characterized avalanche voltage and current
- ◆ Good stability and uniformity with high EAS
- ◆ Excellent package for good heat dissipation
- ◆ Special process technology for high ESD capability

Application

- ◆ Power switching application
- Hard switched and high frequency circuits







Schematic diagram

Marking and pin assignment

TO-252-2L top view

100% UIS TESTED! 100% ΔVds TESTED!

Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
MJ0117K	MJ0117K	TO-252-2L	-	-	-

Absolute Maximum Ratings (Tc =25 °Cunless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	VDS	100	V
Gate-Source Voltage	Vgs	±20	V
Drain Current-Continuous	ΙD	17	А
Drain Current-Continuous(Tc =100°C)	I D(100℃)	12	А
Pulsed Drain Current	Ідм	60	А
Maximum Power Dissipation	PD	55	W
Single pulse avalanche energy (Note 5)	Eas	28	mJ
Operating Junction and Storage Temperature Range	Tл,Tsтg	-55 To 150	°C

Thermal Characteristic

Thermal Resistance, Junction-to-Case (Note 2) Rejc 2.27 °C/W
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Electrical Characteristics (Tc =25°Cunless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
Off Characteristics		1				
Drain-Source Breakdown Voltage	BVDSS	V _{GS} =0V I _D =250µA	100	110	-	V
Zero Gate Voltage Drain Current	Ipss	V _{DS} =100V,V _{GS} =0V	-	-	1	μA
Gate-Body Leakage Current	Igss	V _{DS} =±20V,V _{DS} =0V	-	-	±100	nA
On Characteristics (Note 3)						
Gate Threshold Voltage	VGS(th)	V _{DS} =V _{GS} ,I _D =250µA	1.2	1.8	2.5	V
Duris Course On Club Durishan		V _{GS} =10V, I _D =5A	-	56	70	mΩ
Drain-Source On-State Resistance	RDS(ON)	V _{GS} =4.5V, I _D =3A	-	65	85	mΩ
Forward Transconductance	g FS	V _{DS} =5V,I _D =5A	12	-	-	S
Dynamic Characteristics (Note 4)				1		
Input Capacitance	Clss		-	1350	-	PF
Output Capacitance	Coss	V _{DS} =25V,V _{GS} =0V F=1.0MHz	-	240	_	PF
Reverse Transfer Capacitance	Crss		-	180	-	PF
Switching Characteristics (Note 4)						
Turn-on Delay Time	t _{d(on)}		-	13.8	-	nS
Turn-on Rise Time	tr	VDD=30V,RL=15Ω	-	9.3	-	nS
Turn-Off Delay Time	td(off)	V _{GS} =10V,R _G =2.5Ω	-	43.8	-	nS
Turn-Off Fall Time	tr	-	-	11.4	-	nS
Total Gate Charge	Qg		-	30	-	nC
Gate-Source Charge	Qgs	V _{DS} =30V,I _D =5A V _{GS} =10V	-	6.4	-	nC
Gate-Drain Charge	Qgd		-	8.6	-	nC
Drain-Source Diode Characteristics				<u> </u>	<u> </u>	
Diada Faranad Valuaria (Note 3)	VsD	V _{GS} =0V,I _S =17A	-	_	1.2	V
Diode Forward Voltage (Note 3)		1				
Diode Forward Current (Note 2)	Is		-	-	17	Α

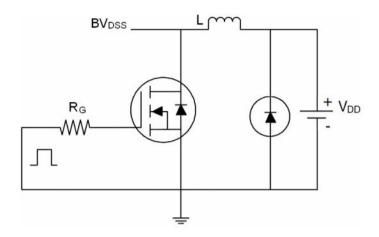
Notes:

- ① Repetitive Rating: Pulse width limited by maximum junction temperature.
- ② Surface Mounted on FR4 Board, t ≤ 10 sec.
- 3 Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2%.
- 4 Guaranteed by design, not subject to production
- \bigcirc EAS condition: Tj=25°C,VDD=50V,VG=10V,L=0.5mH,Rg=25 Ω

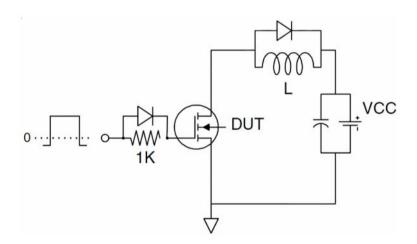




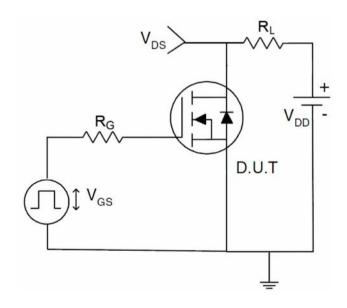
Test circuit



Eas test Circuit



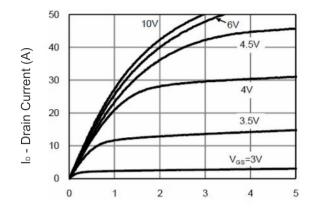
Gate charge test Circuit



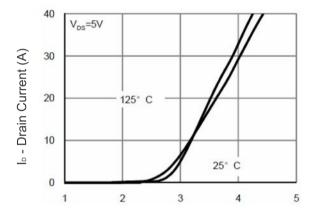
Switch Time Test Circuit



Typical Electrical and Thermal Characteristics (Curves)



Vds Drain-Source Voltage (V) Figure 1 Output Characteristics



Vgs Gate-Source Voltage (V) Figure 2 Transfer Characteristics

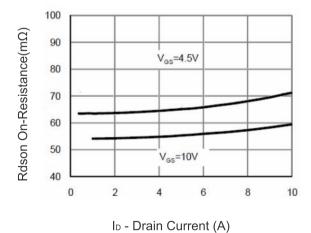
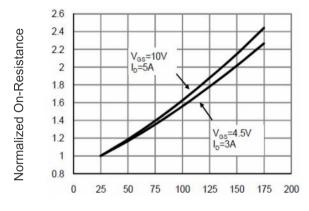
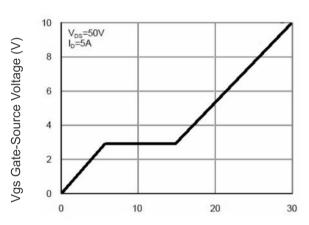


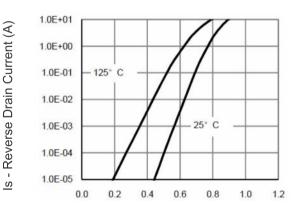
Figure 3 Rdson- Drain Current



T_J -Junction Temperature(°C) Figure 4 Rdson-Junction Temperature



Qg Gate Charge (nC) Figure 5 Gate Charge

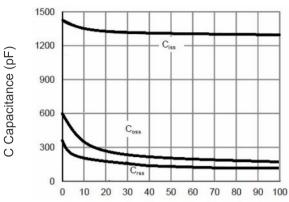


Vsd Source-Drain Voltage (V) Figure 6 Source- Drain Diode Forward

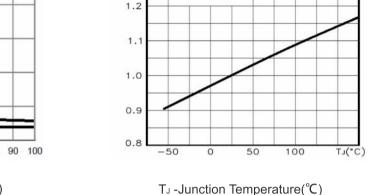
BVDSS

(norm)





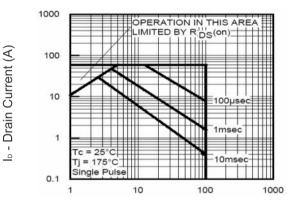
Vds Drain-Source Voltage (V) Figure 7 Capacitance vs Vds



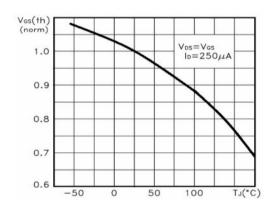
V_{GS}=0

In=250μA

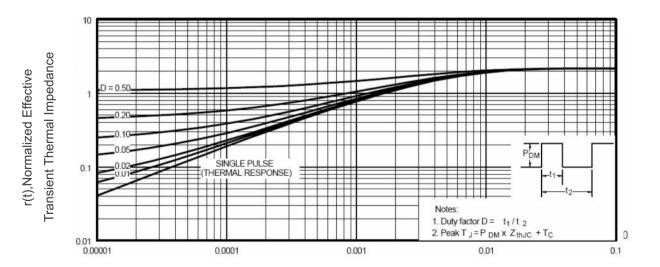
Figure 9 BVpss vs Junction Temperature



Vds Drain-Source Voltage (V) Figure 8 Safe Operation Area



T_J -Junction Temperature(°C) Figure 10 V_{GS(th)} vs Junction Temperature



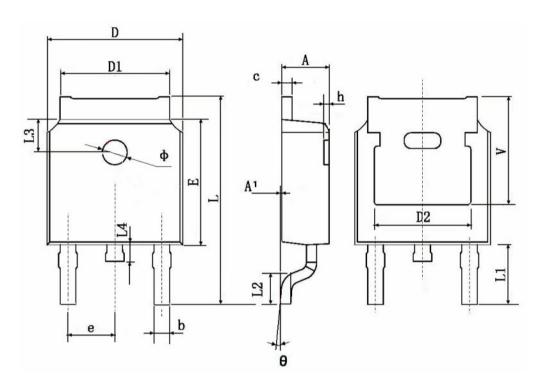
Square Wave Pluse Duration(sec)

Figure 11 Normalized Maximum Transient Thermal Impedance





TO-252 Package Information



Cumbal	Dimensions	In Millimeters	Dimension	s In Inches
Symbol	Min.	Max.	Min.	Max.
А	2.200	2.400	0.087	0.094
A1	0.000	0.127	0.000	0.005
b	0.660	0.860	0.026	0.034
С	0.460	0.580	0.018	0.023
D	6.500	6.700	0.256	0.264
D1	5.100	5.460	0.201	0.215
D2	4.8	30 TYP.	0.190 TYP.	
E	6.000	6.200	0.236	0.244
е	2.186	2.386	0.086	0.094
L	9.800	10.400	0.386	0.409
L1	2.900 TYP.		0.114 TYP.	
L2	1.400	1.700	0.055	0.067
L3	1.600 TYP.		0.063	TYP.
L4	0.600	1.000	0.024	0.039
Ф	1.100	1.300	0.043	0.051
θ	0°	8°	0°	8°
h	0.000	0.300	0.000	0.012
V	5.350 TYP.		0.211	TYP.





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